

Notice of References Cited

Application/Control No.

10/051,898

Applicant(s)/Patent Under
Reexamination
KWUN ET AL.

Examiner

Nashmiya S. Fayyaz

Art Unit

2856

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,591,912	01-1997	Spisak et al.	73/623
	B	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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